Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
08870762	DUFT ET AL.
Examiner	Art Unit
S Devi Ph D	1645

SEARCHED				
Subclass	Date	Examiner		

SEARCH NOTES			
Search Notes	Date	Examiner	
Consultations with tQAS Witz & Wax. SPE Eyler & Stucker.	April, 08	SD	
Appeal conference - Conferess SPE Jeff Stucker & SPE Mondesi	October, 08	SD	

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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